Sheet 1 of 1

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FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

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#### REFERENCE DESIGNATION

#### **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
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pe	1B	4,534,016	8/6/1985	Conilee, Kirkpatrick G.	365	128
KL	1C	4,600,839	7/15/1986	Ichihashi, Mikio, et al.	250	310
(4	1D	4,760,567	7/26/1988	Crewe, Albert V., et al.	369	101
kc	1E	5,402,410	3/28/1995	Yoshimura, Toshiyuki	369	275.1
u	1F	5,835,477	11/10/1998	Binnig, Gerd Karl, et al.	369	126
ice	1G	5,724,336	3/3/1998	Morton, Steven G.	369	126
Kr	1H	5,623,295	4/22/1997	Kishi, Etsuro, et al.	347	111
ye.	11	5,537,372	7/16/1996	Albrecht, Thomas R., et al	369	43
W	1J	5,307,311	4/26/1994	Sliwa, John W., Jr.	365	174
w	1K	5,216,631	6/1/1993	Sliwa, John W., Jr.	365	174

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### OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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